

<b>Notice of References Cited</b>	Application/Control No. 10/750,345		Applicant(s)/Patent Under Reexamination VANDERVEEN ET AL.	
	Examiner Deanna K. Hall		Art Unit 3767	Page 1 of 1

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*	B	US-5,087,245 A	02-1992	Doan, David	604/67
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	K	US-			
	L	US-			
	M	US-			

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**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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